

<b>Notice of References Cited</b>	Application/Control No. 10/520,704		Applicant(s)/Patent Under Reexamination DE KROON ET AL.	
	Examiner John Freeman		Art Unit 4174	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,794,048 B2	09-2004	Schmitz et al.	428/474.7
*	C	US-2006/0166021 A1	07-2006	De Kroon et al.	428/474.4
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	M	US-			

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	N	WO-99/15432	04-1999	WO	Cahill et al.	
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#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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